



# **High-Speed Switching Applications**

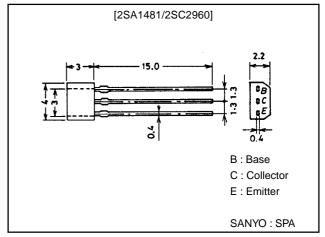
### **Features**

- · Fast switching speed.
- · High breakdown voltage.

# **Package Dimensions**

unit:mm

2033



### (): 2SA1481

# **Specifications**

## Absolute Maximum Ratings at Ta = 25°C

Parameter	Symbol	Conditions	Ratings	Unit
Collector-to-Base Voltage	V <sub>CBO</sub>		(–)60	V
Collector-to-Emitter Voltage	VCEO		(–)50	V
Emitter-to-Base Voltage	V <sub>EBO</sub>		(-)5	V
Collector Current	l <sub>C</sub>		(–)150	mA
Peak Collector Current	I <sub>CP</sub>		(–)400	mA
Collector Dissipation	PC		250	mW
Junction Temperature	Tj		150	°C
Storage Temperature	Tstg		-55 to +150	°C

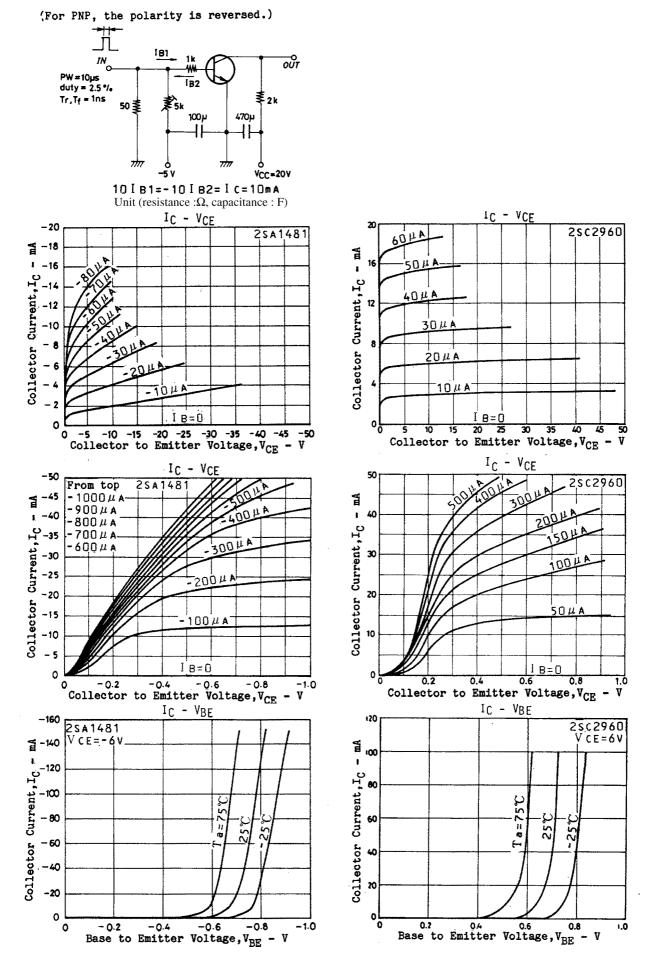
#### Electrical Characteristic at Ta = 25°C

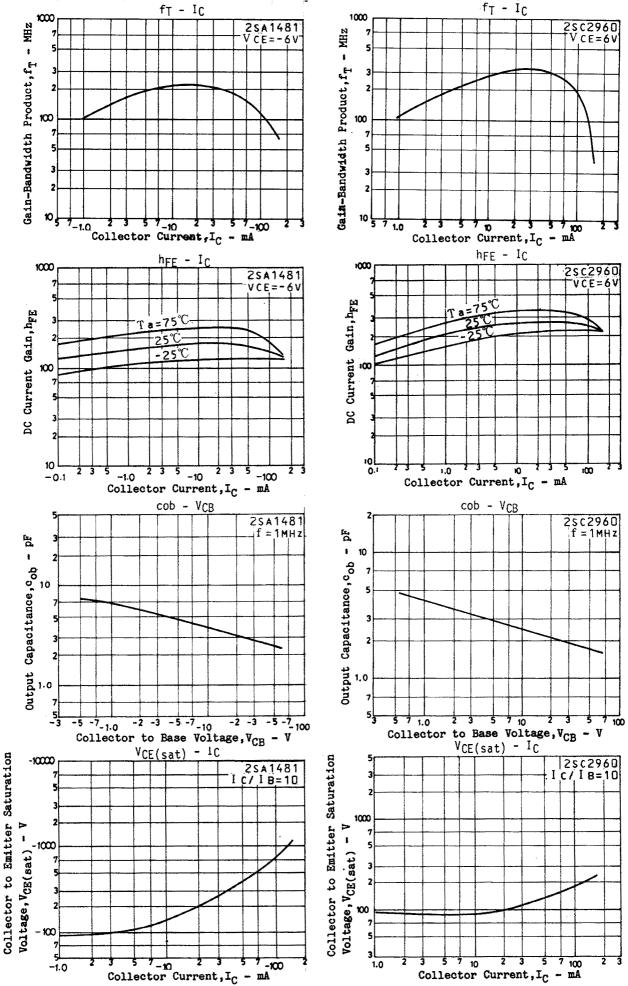
Parameter	Cumbal	Conditions		Ratings		
	Symbol		min	typ	max	Unit
Collector Cutoff Current	I <sub>CBO</sub>	V <sub>CB</sub> =(-)400V, I <sub>E</sub> =0			(–)0.1	μΑ
Emitter Cutoff Current	I <sub>EBO</sub>	V <sub>EB</sub> =(-)4V, I <sub>C</sub> =0			(–)0.1	μΑ
DC Current Gain	hFE	V <sub>CE</sub> =(-)6V, I <sub>C</sub> =(-)1mA	100*		560*	
Gain-Bandwidth Product	f <sub>T</sub>	V <sub>CE</sub> =(-)6V, I <sub>C</sub> =(-)1mA		100		MHz
Output Capacitance	C <sub>ob</sub>	V <sub>CB</sub> =(-)6V, f=1MHz		2.7		pF
				(4.0)		pF
Collector-to-Emitter Saturation Voltage	V <sub>CE(sat)</sub>	I <sub>C</sub> =(-)10mA, I <sub>B</sub> =(-)1mA		(-)0.1	(-)0.4	V
Base-to-Emitter Saturation Voltage	V <sub>BE(sat)</sub>	I <sub>C</sub> =(-)10mA, I <sub>B</sub> =(-)1mA		(-)0.75	(-)1.1	V
Collector-to-Base Breakdown Voltage	V <sub>(BR)CBO</sub>	I <sub>C</sub> =(-)10μΑ, I <sub>E</sub> =0	(–)60			V
Collector-to-Emitter Breakdown Voltage	V <sub>(BR)</sub> CEO	I <sub>C</sub> =(-)1mA, R <sub>BE</sub> =∞	(–)50			V
Emitter-to-Base Breakdown Votage	V(BR)EBO	I <sub>E</sub> =(-)10μΑ, I <sub>C</sub> =0	(–)5			V
Delay Time	t <sub>d</sub>	See specified Test Circuit		40	60	ns
Rise Time	t <sub>r</sub>	See specified Test Circuit		80	130	ns
				(120)	(230)	ns
Storage Time	t <sub>stg</sub>	See specified Test Circuit		230	450	ns
				(190)	(700)	ns
Fall Time	t <sub>f</sub>	See specified Test Circuit		160	250	ns
				(240)	(390)	ns

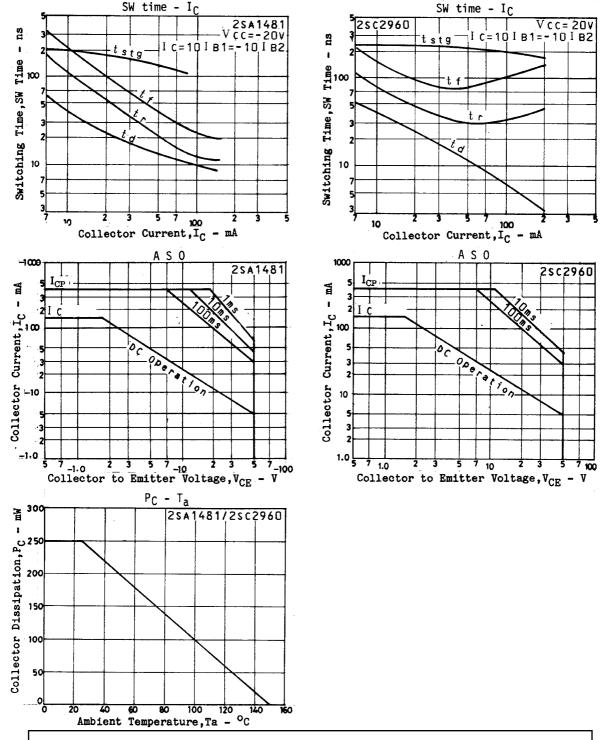
<sup>\* ;</sup> The 2SA1481/2SC2960 are classified by 1mA  $h_{\mbox{\scriptsize FE}}$  as follows :

100 E 200 160 F 320 280 G 560

### **Switching Time Test Circuit**







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